## Notice of References Cited Application/Control No. 10/815,398 | Applicant(s)/Patent Under Reexamination YUEH ET AL. Examiner | Art Unit | 1752 | Page 1 of 1 U.S. PATENT DOCUMENTS \* | Document Number | Country Code-Number-Kind Code | MM-YYYYY | Name | Classification | Classification | Classification | Country Code-Number-Kind Code | Country Code-Number-Kind Code | Classification | Code Country Code-Number-Kind Code | Classification | Code Country Code-Number-Kind Code | Classification | Code Country Code-Number-Kind Code | Classification | Classification | Code Country Code-Number-Kind Code | Classification | Classification

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0147915 A1	07-2005	Dammel, Ralph R.	430/270.1
	В	US-			
	O	US-			
	ם	US-			
	ш	US-			
	F	US-			
	G	US-			
	Ή	US-			
	-	US-			
	7	US-			
	K	US-			
	L	US-			
	Σ	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.